# SN54F11, SN74F11 TRIPLE 3-INPUT POSITIVE-AND GATES

SDFS040A - MARCH 1987 - REVISED OCTOBER 1993

 Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

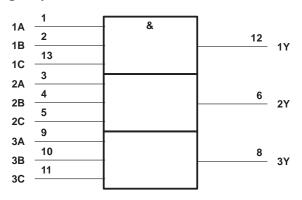
## description

These devices contain three independent 3-input AND gates. They perform the Boolean functions  $Y = A \cdot B \cdot C$  or  $Y = \overline{A} + \overline{B} + \overline{C}$  in positive logic.

The SN54F11 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74F11 is characterized for operation from 0°C to 70°C.

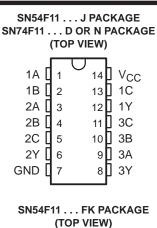
	FUNCTION TABLE (each gate)								
I		INPUTS	OUTPUT						
I	Α	В	С	Y					
I	Н	Н	Н	Н					
	L	Х	Х	L					
	Х	L	Х	L					
	Х	Х	L	L					

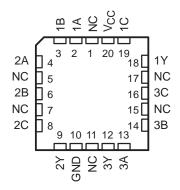
### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

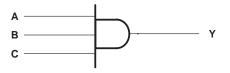
Pin numbers shown are for the D, J, and N packages.





NC - No internal connection

## logic diagram, each gate (positive logic)



PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)	
Input current range	
Voltage range applied to any output in the high state	
Current into any output in the low state	40 mÅ
Operating free-air temperature range: SN54F11	. −55°C to 125°C
SN74F11	0°C to 70°C
Storage temperature range	. −65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.

#### recommended operating conditions

		SN54F11		SN74F11			UNIT	
			NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
Iк	Input clamp current			-18			-18	mA
ЮН	High-level output current			- 1			- 1	mA
IOL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS			SN54F11			SN74F11		
PARAMETER			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	lı = – 18 mA			-1.2			-1.2	V
Veri	V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = – 1 mA	2.5	3.4		2.5	3.4		v
VOH	V <sub>CC</sub> = 4.75 V,	I <sub>OH</sub> = – 1 mA				2.7			
VOL	V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 20 mA		0.3	0.5		0.3	0.5	V
l	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
ΙΗ	V <sub>CC</sub> = 5.5 V,	$V_{I} = 2.7 V$			20			20	μΑ
Ι <sub>Ι</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V			- 0.6			- 0.6	mA
IOS§	V <sub>CC</sub> = 5.5 V,	$V_{O} = 0$	-60		-150	-60		-150	mA
ІССН	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 4.5 V		4.1	6.2		4.1	6.2	mA
ICCL	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0		6.5	9.7		6.5	9.7	mA

<sup>‡</sup> All typical values are at V<sub>CC</sub> = 5 V,  $T_A = 25^{\circ}C$ .

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.



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# switching characteristics (see Note 2)

		,								
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 5 V, C <sub>L</sub> = 50 pF, R <sub>L</sub> = 500 Ω, T <sub>A</sub> = 25°C		V <sub>CC</sub> = 4.5 V to 5.5 V, C <sub>L</sub> = 50 pF, R <sub>L</sub> = 500 Ω, T <sub>A</sub> = MIN to MAX <sup>†</sup>				UNIT	
			′F11		SN54F11		SN74F11			
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	ABorC	A, B, or C Y	2.2	3.8	5.6	1.7	7.5	2.2	6.6	ns
<sup>t</sup> PHL	A, B, OI C		1.7	3.7	5.5	1.2	7.5	1.7	6.5	

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 2: Load circuits and waveforms are shown in Section 1.



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